Features

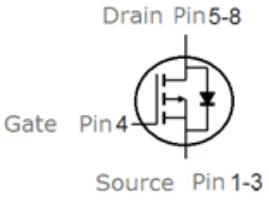
- P-Channel，-2.5V Logic Level Control
- Low on-resistance RDS(on) @ V_{GS}=-2.5 V
- Fast Switching
- Enhancement mode
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant

Pb-Free RoHS HF Halogen-Free

V_{DS}	-20	V
$R_{DS(on),TYP}$@ V_{GS}=-4.5 V	5.8	mΩ
$R_{DS(on),TYP}$@ V_{GS}=-2.5V	8	mΩ
I_D	-65	A

PDFN3333

Part ID	Package Type	Marking	Tape and reel information
VSE003P02KS	PDFN3333	003P02K	5000pcs/reel



Maximum ratings, at T_A =25°C, unless otherwise specified

Symbol	Parameter		Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage		-20	V
VGS	Gate-Source voltage		±12	V
I_S	Diode continuous forward current	T_C =25°C	-65	A
I_D	Continuous drain current @VGS=-4.5V	T_C =25°C	-65	A
		T_C =100°C	-41	A
I_{DM}	Pulse drain current tested ①	T_C =25°C	-260	A
I_{DSM}	Continuous drain current @VGS=-4.5V	T_A=25°C	19	A
		T_A=70°C	15	A
EAS	Avalanche energy, single pulsed ②		20	mJ
P_D	Maximum power dissipation	T_C =25°C	42	W
P_{DSM}	Maximum power dissipation ③	T_A=25°C	3.5	W
MSL			Level 3	
T_{STG}, T_J	Storage and Junction Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	35	°C/W

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Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=-250μA	-20	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current(Tc=25℃)	V_{DS}=-20V,V_{GS}=0V	--	--	-1	μA
	Zero Gate Voltage Drain Current(Tc=125℃)	V_{DS}=-20V,V_{GS}=0V	--	--	-100	μA
I_{GSS}	Gate-Body Leakage Current	V_{GS}=±12V,V_{DS}=0V	--	--	±100	nA
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS}=V_{GS},I_D=-250μA	-0.4	-0.6	-1	V
$R_{DS(ON)}$	Drain-Source On-State Resistance ④	V_{GS}=-4.5V, I_D=-20A	--	5.8	8	mΩ
$R_{DS(ON)}$	Drain-Source On-State Resistance ④	V_{GS}=-2.5V, I_D=-12A	--	8	11	mΩ
$R_{DS(ON)}$	Drain-Source On-State Resistance ④	V_{GS}=-1.8V, I_D=-10A	--	12	15	mΩ
Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
C_{iss}	Input Capacitance	V_{DS}=-10V,V_{GS}=0V, f=1MHz	5800	6340	6800	pF
C_{oss}	Output Capacitance		650	725	800	pF
C_{rss}	Reverse Transfer Capacitance		550	615	680	pF
R_g	Gate Resistance	f=1MHz	--	3.5	--	Ω
Q_g	Total Gate Charge	V_{DS}=-10V,I_D=-20A, V_{GS}=-4.5V	--	72	--	nC
Q_{gs}	Gate-Source Charge		--	11.2	--	nC
Q_{gd}	Gate-Drain Charge		--	20.4	--	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	V_{DD}=-10V, I_D=-20A, R_G=3Ω, V_{GS}=-4.5V	--	20	--	nS
t_r	Turn-on Rise Time		--	54	--	nS
$t_{d(off)}$	Turn-Off Delay Time		--	287	--	nS
t_f	Turn-Off Fall Time		--	125	--	nS
Source- Drain Diode Characteristics@ T_J = 25°C (unless otherwise stated)						
V_{SD}	Forward on voltage	I_{SD}=-20A,V_{GS}=0V	--	-0.8	-1.2	V
t_{rr}	Reverse Recovery Time	T_j=25℃,I_{sd}=-20A, V_{GS}=0V di/dt=-500A/μs	--	80	--	nS
Q_{rr}	Reverse Recovery Charge		--	497	--	nC

NOTE:

① Repetitive rating; pulse width limited by max junction temperature.

② Limited by TJmax, starting TJ = 25°C, L = 0.5mH, RG = 25Ω, IAS = -9A, VGS =-4.5V. Part not recommended for use above this value

③ The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C.

④ Pulse width ≤ 300μs; duty cycle≤ 2%.

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Typical Characteristics

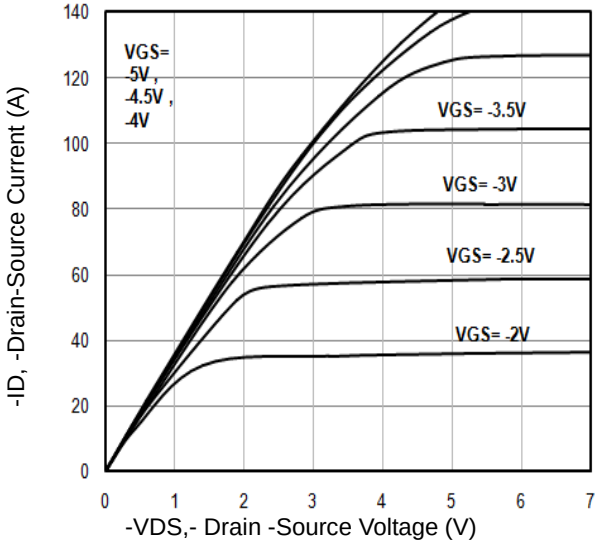

Fig1. Typical Output Characteristics

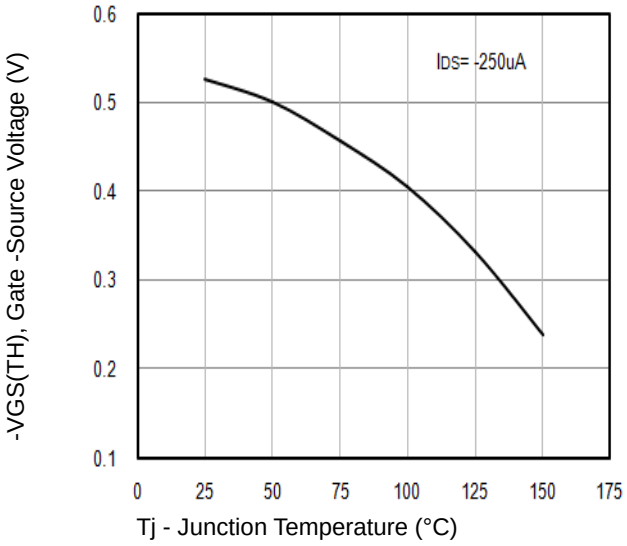

Fig2. $-V_{GS(TH)}$ Gate -Source Voltage Vs.Tj

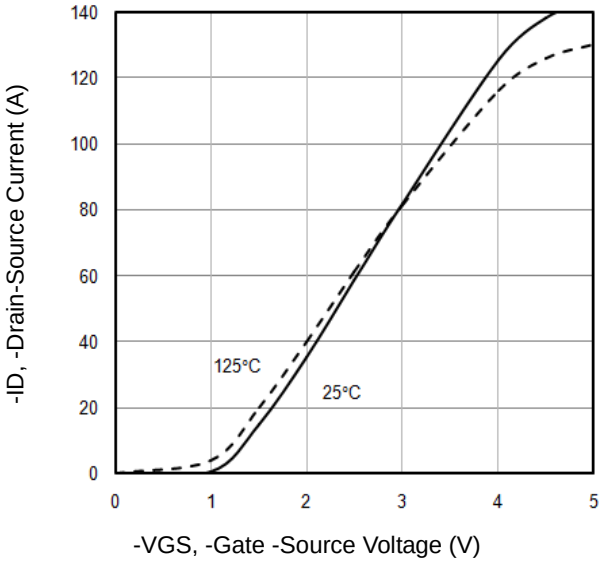

Fig3. Typical Transfer Characteristics

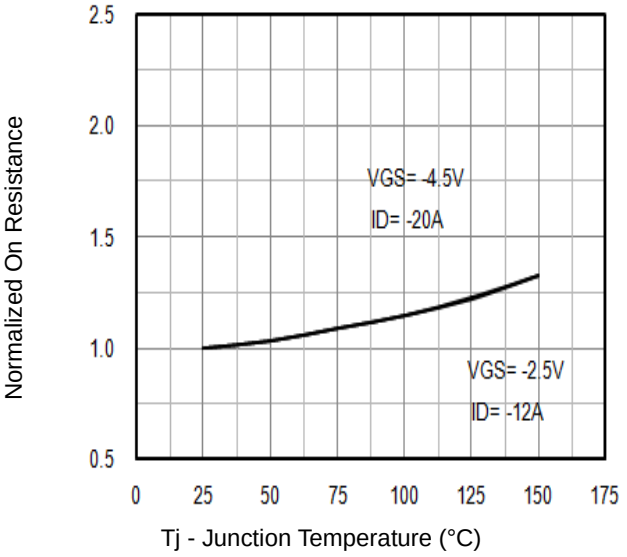

Fig4. Normalized On-Resistance Vs. Tj

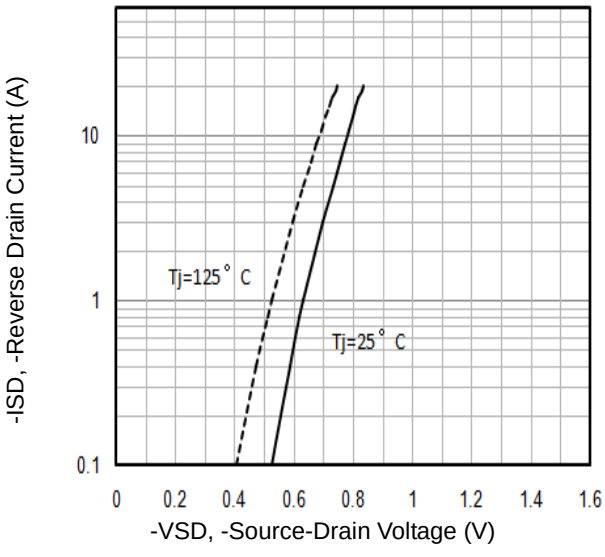

Fig5. Typical Source-Drain Diode Forward Voltage

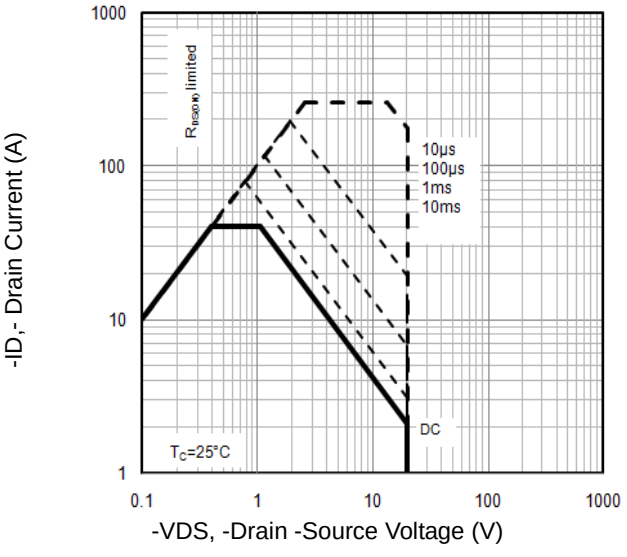

Fig6. Maximum Safe Operating Area

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Typical Characteristics

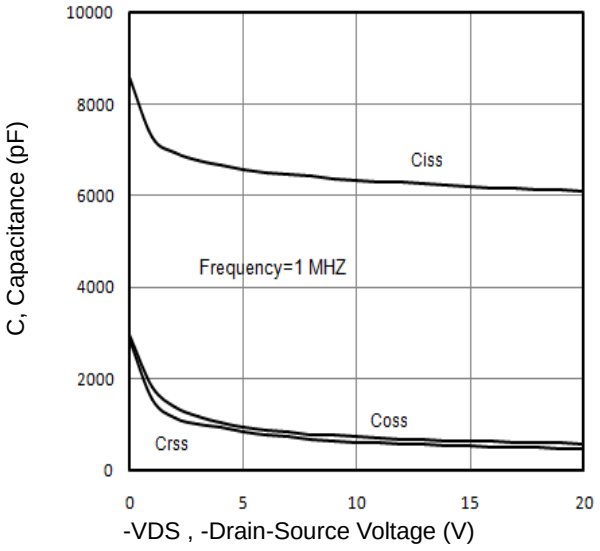

Fig7. Typical Capacitance Vs.Drain-Source Voltage

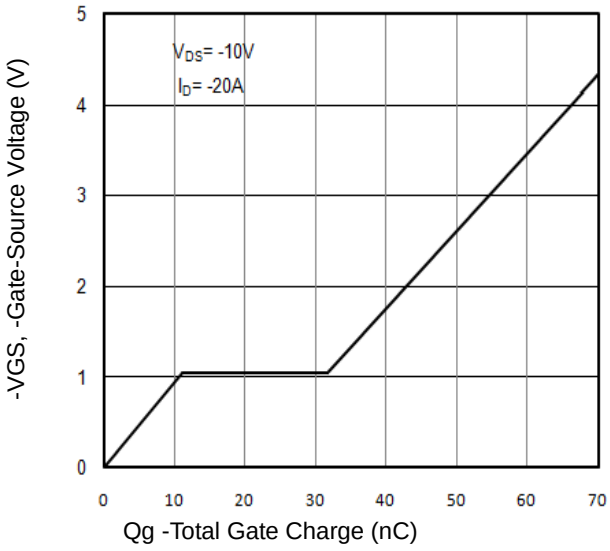

Fig8. Typical Gate Charge Vs.Gate-Source Voltage

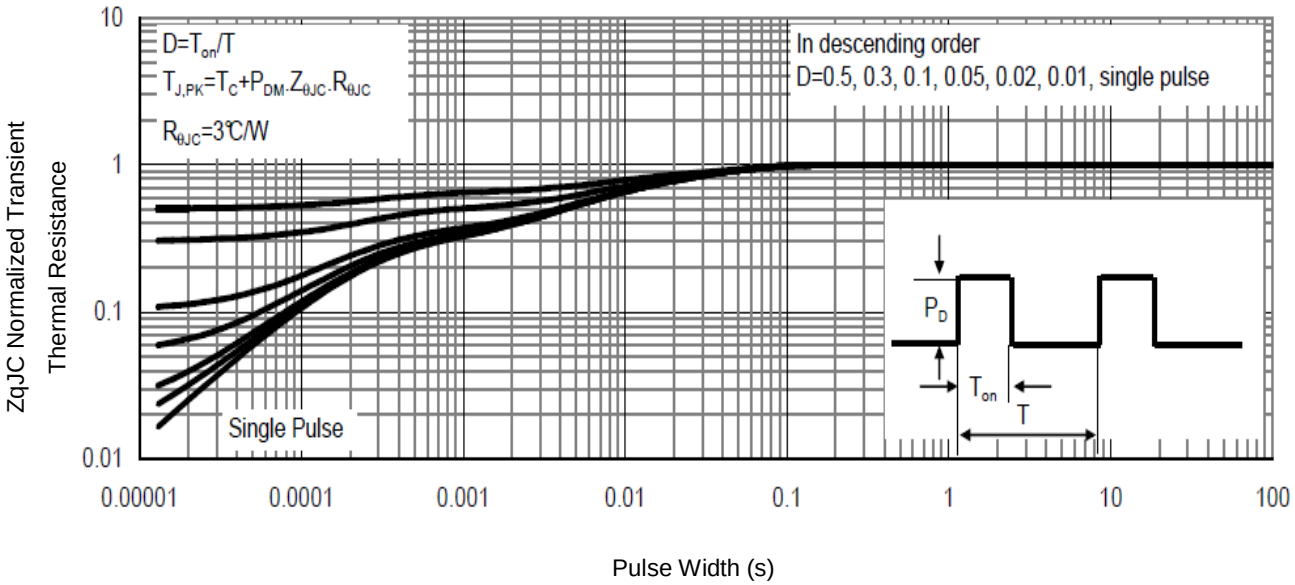

Fig9. Normalized Maximum Transient Thermal Impedance

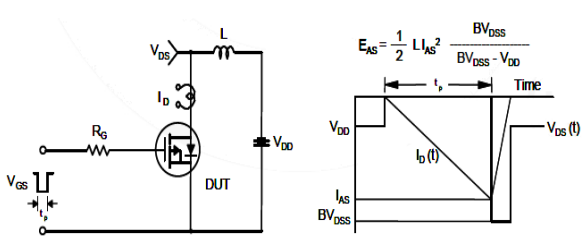

Fig10. Unclamped Inductive Test Circuit and Waveforms

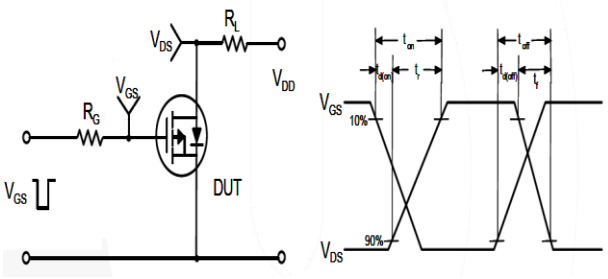

Fig11. Switching Time Test Circuit and waveforms

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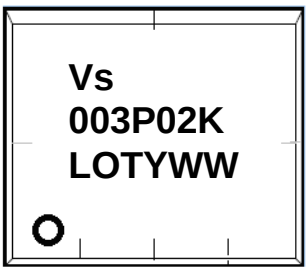
Marking Information



1st line：Company Code（Vs）
2nd line：Part Number（003P02K）
3rd line：Date code （LOTYWW）
LOT：Wafer Lot Number
Y：Year Code，e.g. E means 2017
WW：Week Code

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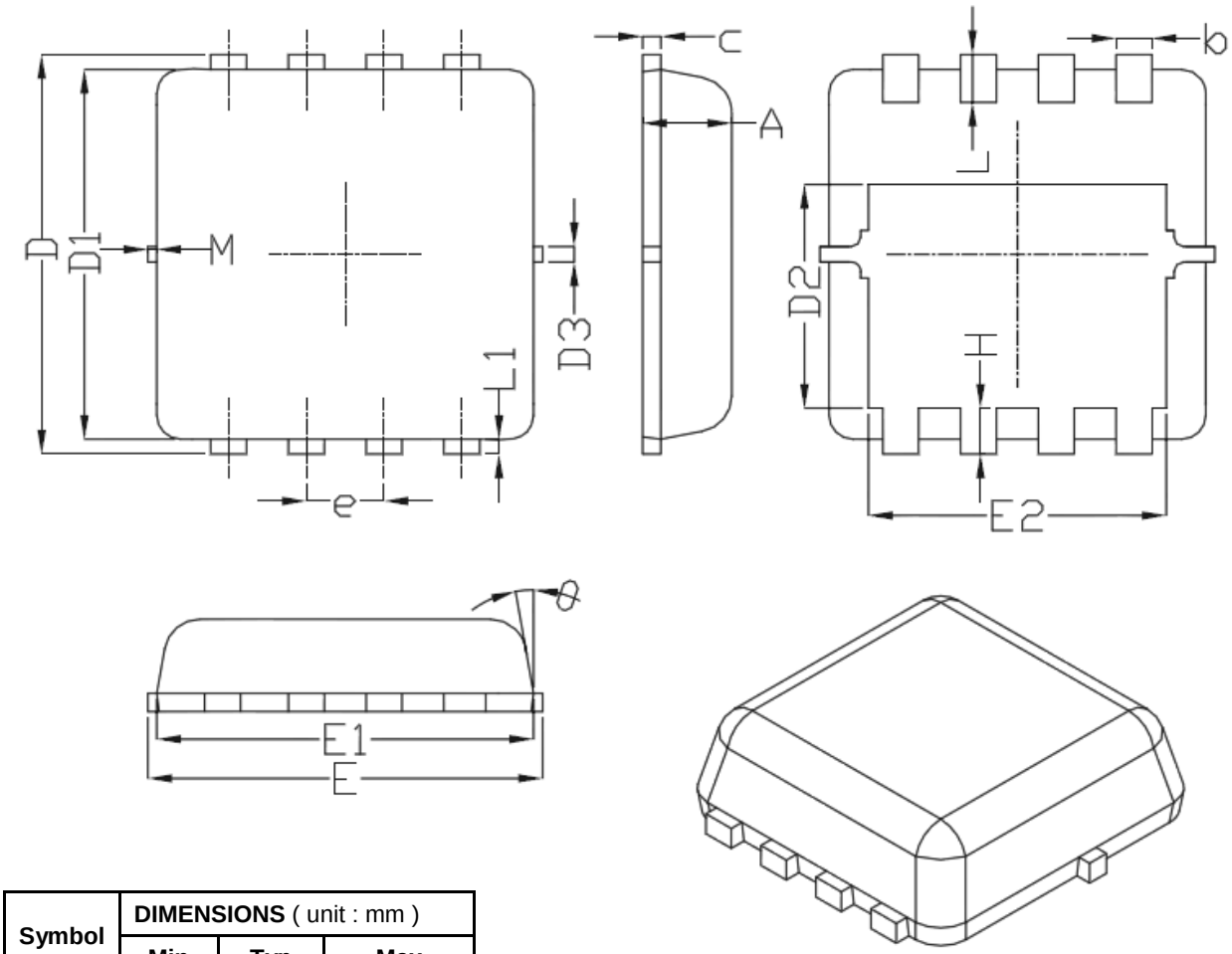
PDFN3333 Package Outline Data



Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	0.7	0.75	0.8
b	0.25	0.3	0.35
C	0.1	0.15	0.25
D	3.25	3.35	3.45
D1	3	3.1	3.2
D2	1.78	1.88	1.98
D3	--	0.13	--
E	3.2	3.3	3.4
E1	3	3.15	3.2
E2	2.39	2.49	2.59
e	0.65 BSC		
H	0.3	0.39	0.5
L	0.3	0.4	0.5
L1	--	0.13	--
θ	--	10°	12°
M	*	*	0.15
* Not specified			

Notes:

1. Follow JEDEC MO-240 variation CA.
2. Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.
3. Dimensions "D1" and "E1" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.

Customer Service

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